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1 INTRODUCTION

This document contains a summary of the requirements set forth by the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards for reference dipoles used for SAR measurement system validations and the measurements that were performed to verify that the product complies with the fore mentioned standards.

2 DEVICE UNDER TEST

Device Under Test	
Device Type	COMOSAR 750 MHz REFERENCE DIPOLE
Manufacturer	Satimo
Model	SID750
Serial Number	SN 25/13 DIP 0G750-253
Product Condition (new / used)	New

A yearly calibration interval is recommended.

3 PRODUCT DESCRIPTION

3.1 GENERAL INFORMATION

Satimo's COMOSAR Validation Dipoles are built in accordance to the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards. The product is designed for use with the COMOSAR test bench only.

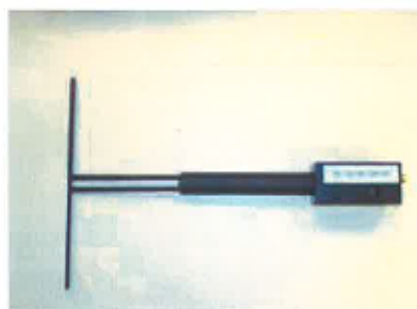


Figure 1 – Satimo COMOSAR Validation Dipole

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4 MEASUREMENT METHOD

The IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards provide requirements for reference dipoles used for system validation measurements. The following measurements were performed to verify that the product complies with the fore mentioned standards.

4.1 RETURN LOSS REQUIREMENTS

The dipole used for SAR system validation measurements and checks must have a return loss of -20 dB or better. The return loss measurement shall be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards.

4.2 MECHANICAL REQUIREMENTS

The IEEE Std. 1528 and CEI/IEC 62209 standards specify the mechanical components and dimensions of the validation dipoles, with the dimensions frequency and phantom shell thickness dependent. The COMOSAR test bench employs a 2 mm phantom shell thickness therefore the dipoles sold for use with the COMOSAR test bench comply with the requirements set forth for a 2 mm phantom shell thickness.

5 MEASUREMENT UNCERTAINTY

All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

5.1 RETURN LOSS

The following uncertainties apply to the return loss measurement:

Frequency band	Expanded Uncertainty on Return Loss
400-6000MHz	0.1 dB

5.2 DIMENSION MEASUREMENT

The following uncertainties apply to the dimension measurements:

Length (mm)	Expanded Uncertainty on Length
3 - 300	0.05 mm

5.3 VALIDATION MEASUREMENT

The guidelines outlined in the IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty for validation measurements.

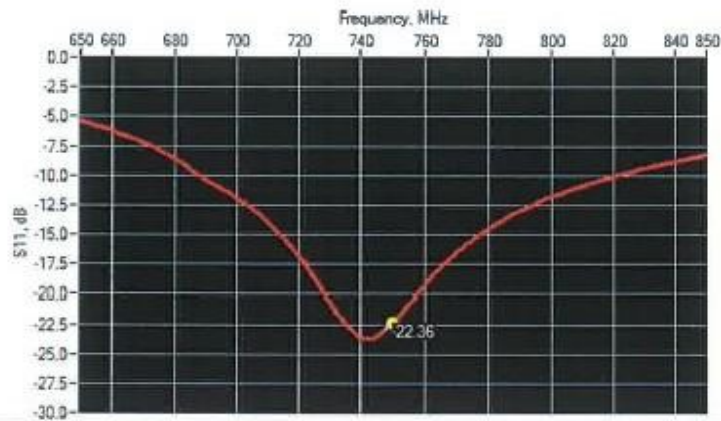
Scan Volume	Expanded Uncertainty
1 g	20.3 %
10 g	20.1 %

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6 CALIBRATION MEASUREMENT RESULTS

6.1 RETURN LOSS



Frequency (MHz)	Return Loss (dB)	Requirement (dB)
750	-22.36	-20

6.2 MECHANICAL DIMENSIONS

Frequency MHz	L mm		h mm		d mm	
	required	measured	required	measured	required	measured
300	420.0 ±1 %		250.0 ±1 %		6.35 ±1 %	
450	290.0 ±1 %		166.7 ±1 %		6.35 ±1 %	
750	176.0 ±1 %	PASS	100.0 ±1 %	PASS	6.35 ±1 %	PASS
835	161.0 ±1 %		89.8 ±1 %		3.6 ±1 %	
900	149.0 ±1 %		83.3 ±1 %		3.6 ±1 %	
1450	89.1 ±1 %		51.7 ±1 %		3.6 ±1 %	
1500	80.5 ±1 %		50.0 ±1 %		3.6 ±1 %	
1640	79.0 ±1 %		45.7 ±1 %		3.6 ±1 %	
1750	75.2 ±1 %		42.9 ±1 %		3.6 ±1 %	
1800	72.0 ±1 %		41.7 ±1 %		3.6 ±1 %	
1900	68.0 ±1 %		39.5 ±1 %		3.6 ±1 %	
1950	66.3 ±1 %		38.5 ±1 %		3.6 ±1 %	
2000	64.5 ±1 %		37.5 ±1 %		3.6 ±1 %	
2100	61.0 ±1 %		35.7 ±1 %		3.6 ±1 %	
2300	55.5 ±1 %		32.6 ±1 %		3.6 ±1 %	
2450	51.5 ±1 %		30.4 ±1 %		3.6 ±1 %	
2600	48.5 ±1 %		28.8 ±1 %		3.6 ±1 %	
3000	41.5 ±1 %		25.0 ±1 %		3.6 ±1 %	
3500	37.0 ±1 %		26.4 ±1 %		3.6 ±1 %	
3700	34.7 ±1 %		26.4 ±1 %		3.6 ±1 %	

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7 VALIDATION MEASUREMENT

The IEEE Std. 1528, OET 65 Bulletin C and CEI/IEC 62209 standards state that the system validation measurements must be performed using a reference dipole meeting the fore mentioned return loss and mechanical dimension requirements. The validation measurement must be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards. Per the standards, the dipole shall be positioned below the bottom of the phantom, with the dipole length centered and parallel to the longest dimension of the flat phantom, with the top surface of the dipole at the described distance from the bottom surface of the phantom.

7.1 MEASUREMENT CONDITION

Software	OPENSAR V4
Phantom	SN 20/09 SAM71
Probe	SN 18/11 EPG122
Liquid	Head Liquid Values: ϵ_r' : 42.4 sigma : 0.88
Distance between dipole center and liquid	15.0 mm
Area scan resolution	$dx=8mm/dy=8mm$
Zoon Scan Resolution	$dx=8mm/dy=8m/dz=5mm$
Frequency	750 MHz
Input power	20 dBm
Liquid Temperature	21 °C
Lab Temperature	21 °C
Lab Humidity	45 %

7.2 HEAD LIQUID MEASUREMENT

Frequency MHz	Relative permittivity (ϵ_r')		Conductivity (σ) S/m	
	required	measured	required	measured
300	45.3 ±5 %		0.87 ±5 %	
450	43.5 ±5 %		0.87 ±5 %	
750	41.9 ±5 %	PASS	0.89 ±5 %	PASS
835	41.5 ±5 %		0.90 ±5 %	
900	41.5 ±5 %		0.97 ±5 %	
1450	40.5 ±5 %		1.20 ±5 %	
1500	40.4 ±5 %		1.23 ±5 %	
1640	40.2 ±5 %		1.31 ±5 %	
1750	40.1 ±5 %		1.37 ±5 %	
1800	40.0 ±5 %		1.40 ±5 %	
1900	40.0 ±5 %		1.40 ±5 %	
1950	40.0 ±5 %		1.40 ±5 %	
2000	40.0 ±5 %		1.40 ±5 %	
2100	39.8 ±5 %		1.49 ±5 %	
2300	39.5 ±5 %		1.67 ±5 %	
2450	39.2 ±5 %		1.80 ±5 %	
2600	39.0 ±5 %		1.96 ±5 %	
3000	38.5 ±5 %		2.40 ±5 %	
3500	37.9 ±5 %		2.91 ±5 %	

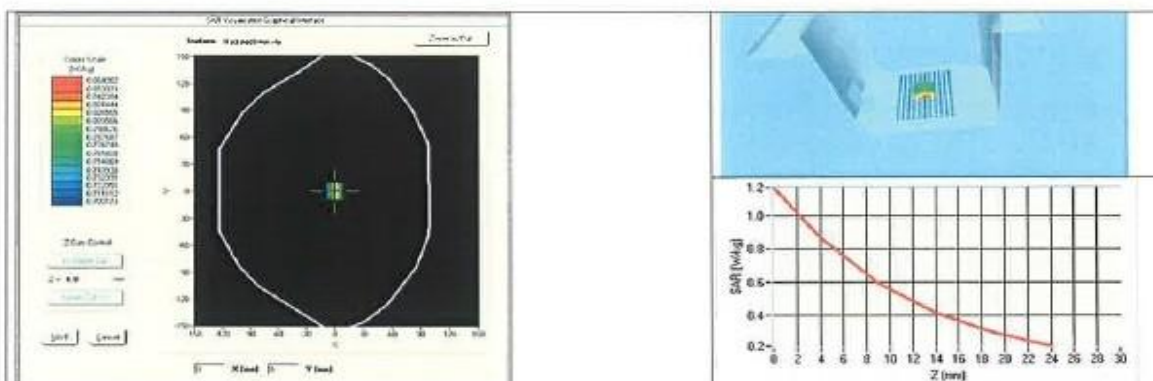
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7.3 MEASUREMENT RESULT

The IEEE Std. 1528 and CEI/IEC 62209 standards state that the system validation measurements should produce the SAR values shown below (for phantom thickness of 2 mm), within the uncertainty for the system validation. All SAR values are normalized to 1 W forward power. In bracket, the measured SAR is given with the used input power.

Frequency MHz	1 g SAR (W/kg/W)		10 g SAR (W/kg/W)	
	required	measured	required	measured
300	2.85		1.94	
450	4.58		3.06	
750	8.49	8.19 (0.82)	5.55	5.34 (0.53)
835	9.56		6.22	
900	10,9		6.99	
1450	29		16	
1500	30,5		16.8	
1640	34,2		18,4	
1750	36,4		19,3	
1800	38,4		20,1	
1900	39,7		20,5	
1950	40,5		20,9	
2000	41,1		21,1	
2100	43,6		21,9	
2300	48,7		23,3	
2450	52,4		24	
2600	55,3		24,6	
3000	63,8		25,7	
3500	67,1		25	



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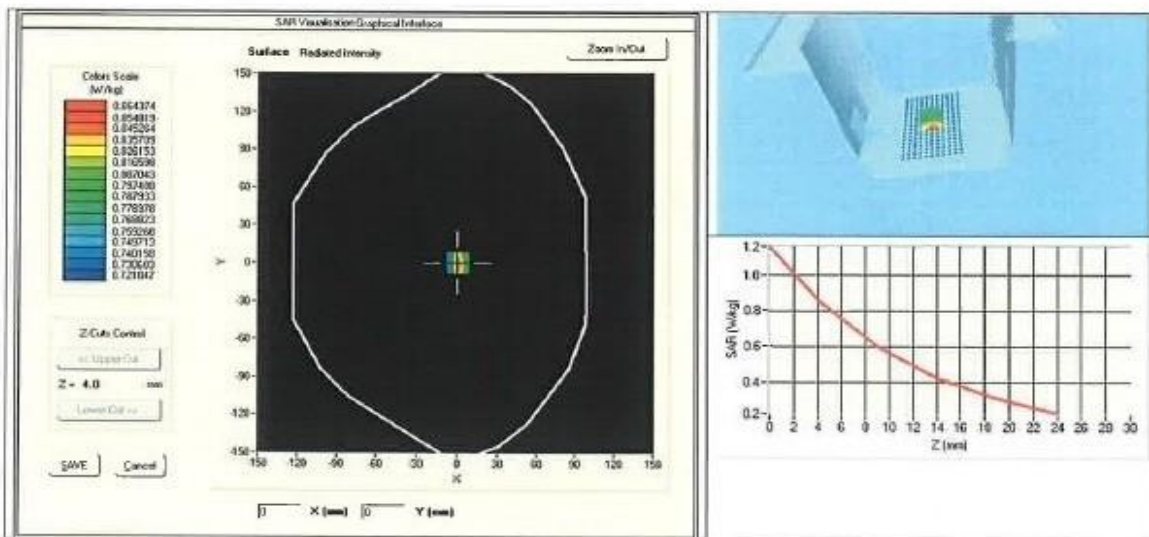
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7.4 BODY MEASUREMENT RESULT

Software	OPENSAR V4
Phantom	SN 20/09 SAM71
Probe	SN 18/11 EPG122
Liquid	Body Liquid Values: $\epsilon_s' : 55.7$ $\sigma : 0.96$
Distance between dipole center and liquid	15.0 mm
Area scan resolution	$dx=8mm/dy=8mm$
Zoon Scan Resolution	$dx=8mm/dy=8mm/dz=5mm$
Frequency	750 MHz
Input power	20 dBm
Liquid Temperature	21 °C
Lab Temperature	21 °C
Lab Humidity	45 %

Frequency MHz	1 g SAR (W/kg/W)	10 g SAR (W/kg/W)
	measured	measured
750	8.21 (0.82)	5.43 (0.54)





8 LIST OF EQUIPMENT

Equipment Summary Sheet				
Equipment Description	Manufacturer / Model	Identification No.	Current Calibration Date	Next Calibration Date
SAM Phantom	Satimo	SN-20/09-SAM71	Validated. No cal required.	Validated. No cal required.
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No cal required.
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2013	02/2016
Calipers	Carrera	CALIPER-01	12/2012	12/2015
Reference Probe	Satimo	EPG122 SN 18/11	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Multimeter	Keithley 2000	1188656	11/2012	11/2015
Signal Generator	Agilent E4438C	MY49070581	12/2012	12/2015
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Power Meter	HP E4418A	US38261498	11/2012	11/2015
Power Sensor	HP ECP-E26A	US37181460	11/2012	11/2015
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Temperature and Humidity Sensor	Control Company	11-661-9	3/2013	3/2015

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Calibration Certificate of Keithley 2000 Multimeter

KEITHLEY

A Tektronix Company

A Greater Measure of Confidence

TRACEABLE CALIBRATION

2000, 4014020
Cal Date: 30-JAN-2013
Cal Due: Lab: Kel

KEITHLEY

KEITHLEY INSTRUMENTS, INC. • 28775 ACBORA RD, CLEVELAND, OHIO - USA • 419-248-0400 • Fax: 419-248-6168 • 1-888-KEITHLEY • www.keithley.com

Calibration Facility: This product was calibrated for Keithley Instruments by
Tektronix (China) Co. Ltd., 1227 Chuan Qiao Road, Pudong New District, Shanghai, China 201206

Calibration Certificate

Certificate No: PCXPTG6FZX	Revision: 00	Serial No: 4014020
Manufacturer: Keithley	Model: 2000	Humidity: 46 %
Description: Multimeter, 6 1/2 digit	Temperature: 23.0 °C	Date Placed In Service: _____
Calibration Date: 30-JAN-2013		Due Date: _____

* Optional customer entry fields: The due date may be established by adding the Keithley recommended cal interval stated in the product manual to the "Date placed in service"

Initial Condition: Not applicable, new product

Final Condition: In Tolerance

- Keithley Instruments, Inc. certifies that the above instrument meets its published measurement specifications.
- This instrument has been calibrated using measurement standards traceable to the International System of Units (SI) through the PRC National Institute of Metrology (NIM), or other National Metrology Institutes (such as NIST, NPL, PTB, etc.).
- The policies and procedures used for the calibration of this product are based upon ANSI/NCSL Z540.1-1994 (R2002).
- The quality system used by the calibration facility is ISO 9001 registered.
- This calibration is a direct comparison of the unit under test to the listed reference standards and did not involve any sampling plans to complete. No allowance has been made for the instability of the test device due to use, time, etc. Such allowances would be made by the customer as needed.
- This calibration certificate shall not be reproduced, except in full, without the written approval of Keithley Instruments, Inc.

Calibration Procedure Used: MANIFEST:Product_Dmm_KeithleyDMM_Full VERSION:107

Calibration Standards Used:

Manufacturer/Model	Model Description	ID Number	Due Date
Fluke 5720A	Calibrator	KI10138	18-Nov-2013
Fluke 5725A	Power Amplifier	KI5554	09-Jan-2014
Keithley 3390	Function/Arbitrary Waveform Gen	KI10261	16-Nov-2013

Issued By: 
Quality Director: Cui, Hu Wa

Certified By: Lin Qing Zhu
Date Issued: 30-JAN-2013

2000 4014020



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—End of the Report—